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Band gap tuning from an indirect EuGa₂S₄ to a direct EuZnGeS₄ semiconductor: syntheses, crystal and electronic structures, and optical properties†

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Four isostructural europium chalcogenides, EuZnGeS₄ (1), EuGa₂S₄ (2), EuIn₂S₄ (3) and EuIn₂Se₄ (4), have been synthesized using a high-temperature solid-state method. Single-crystal X-ray diffraction analysis indicates that they crystallize in the orthorhombic space group Fddd with Z=32. Their structures feature an MQ₄ (M = Zn, Ge, Ga and In; Q = S and Se) tetrahedrally constructed 3D network, and Eu²⁺ ions occupy the bicapped trigonal prismatic cavities. Compounds 1–3 have optical band gaps of 2.26, 2.32 and 2.37 eV, respectively. Theory calculations indicate that 2, with an indirect band gap, can be tuned to 1, with a direct band gap, via simple chemical substitution.

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Introduction

Rare-earth chalcogenides have been extensively explored in the past twenty years because of their rich structures and potential applications in the fields of magnetism,1 thermoelectricity,2 photoluminescence,3 second-order nonlinear optics,4 and so on. Among them, europium chalcogenides have been paid much attention as Eu ions can be divalent or trivalent. It is well known that the Eu²⁺ cation has a similar ionic radius to alkaliearth metal cations, so many Eu2+ compounds have alkali-earth metal analogues. Recently, many alkali-earth metal chalcogenides have been studied as second-order nonlinear optical materials as they have high nonlinear optical coefficients and laser induced damage thresholds, such as Ba₈Sn₄S₁₅,⁵ $Ba_7Sn_5S_{15}$, $Ba_6Sn_6Se_{13}$, $BaHgSe_2$, $BaHgSe_2$ (ref. 9) and BaCdSnSe₄, which have encouraged many chemists and material scientists' to explore them in the field of laser frequency conversion.

When checking the database, it was discovered that there are a large group of ternary or quaternary compounds can be uniformly written as II-III $_2$ (III-III $_3$)-Ch $_4$ or quaternary II-II $_4$ (I $_2$)-IV-Ch $_4$ (II = Mg, Ca, Sr, Ba, Eu and Yb; II $_3$ = divalent transition metal; I = Li, Na, Cu and Ag; III = B, Al, Ga and In; III $_3$ = Yb, Sb and Bi; IV = Ge and Sn; Ch = S, Se and Te). The representative members of this family are listed in Table 1. What's more, there are also many related II-III $_2$ -Ch $_4$ compounds containing transition-metal reported, where II = divalent transition-metal

Zn, Cd, Hg and Mn, III = Ga and In, and Ch = S and Se. 12 If take EuGa $_2$ S $_4$ as the parent compound for this series, the sites of Eu and S can be also occupied by divalent alkali-earth metal or Yb, and Se or Te, respectively. The Ga sites can be replaced by the same group element B, Al and In. Specially, two Ga sites can be also replaced by two different elements to form quaternary compound II-II'-IV-Ch $_4$ or II-I $_2$ -IV-Ch $_4$, in which one site is occupied by tetravalent cations like Ge and Sn, the other site occupied by divalent transition-metal cations or monovalent coinage or alkali metal cations.

Stimulated by their versatile structure types and potential applications and our rich experience in rare-earth chalcogenides, ¹³ we recently synthesized four such compounds, EuZnGeS₄ (1), EuGa₂S₄ (2), EuIn₂S₄ (3) and EuIn₂Se₄ (4). Compounds 1, 3 and 4 can be viewed as the derivants of 2. Compound 1 is firstly obtained, 3 and 4 are new phases of EuIn₂S₄ and EuIn₂Se₄, respectively, different from the known *Cccm* ones. ¹⁴ Compound 2 was only characterized using powder X-ray diffraction data. ¹⁵ Here, we studied their syntheses, crystal and electronic structures, and optical properties.

Experimental section

Materials

 Eu_2O_3 (99.9%, Aladdin), Zn (99.99%, Aladdin), Ga_2O_3 (99.999%, Aladdin), In_2O_3 (99.9%, Aladdin), Ge (99.999%, Aladdin), S (99.95%, Aladdin), Se (99.999%, Aladdin), B powder (99%, Aladdin) and KI (99.0%, China Sinopharm Chem.).

Syntheses and analyses

All starting materials were used as received without further purification. Single crystals of the title compounds were

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† Electronic supplementary information (ESI) available: Crystallographic files in CIF format and additional tables. See DOI: 10.1039/c6ra25283d

Table 1 Known structure types of ternary II-III₂ (III-III')-Ch₄ or quaternary II-II'(I₂)-IV-Ch₄ (II = Mg, Ca, Sr, Ba, Eu and Yb; II' = divalent transition metal; I = Li, Na, Cu and Ag; III = B, Al, Ga and In; III' = Yb, Sb and Bi; IV = Ge and Sn; Ch = S, Se and Te) compounds. All these data are from ICSD or Pearson's crystal data^a

Compound	Space group	Crystal system	Pearson code	Phase prototype
$MgAl_2S_4$	Pnma	Orthorhombic	oP28	Mg ₂ SiO ₄
MgAl ₂ S ₄	R3m	Trigonal	hR7	$ZnIn_2S_4$
MgAl ₂ S ₄	$R\bar{3}m$	Trigonal	hR7	$ZnIn_2S_4$
$MgGa_2S_4$	C2/c	Monoclinic	mS84	$MgGa_2S_4$
$MgIn_2S_4$	$Fd\bar{3}m$	Cubic	<i>cF</i> 56	$MgAl_2O_4$
MgIn ₂ Te ₄	$I\bar{4}2m$	Tetragonal	tI14	Cu ₂ HgI ₄
SrB_2S_4	$P2_1/c$	Monoclinic	mP28	SrB_2S_4
SrB_2S_4	$R\bar{3}$	Trigonal	hR63	SrB_2S_4
$SrAl_2S_4$	Cccm	Orthorhombic	oS28	BaGe ₂ Se ₄
$SrAl_2S_4$	Fddd	Orthorhombic	oF224	$EuGa_2S_4$
SrGa ₂ Te ₄	I4/mcm	Tetragonal	tI14	CaIn ₂ Te ₄
SrCu ₂ GeSe ₄	Ama2	Orthorhombic	oS32	SrCu ₂ GeSe ₄
$SrCu_2SnS_4$	$P3_1$	Trigonal	hP24	$SrCu_2SnS_4$
$SrCu_2SnS_4$	$P3_{2}21$	Trigonal	hP24	$SrCu_2SnS_4$
BaB_2S_4	Cc	Monoclinic	mS28	BaB_2S_4
$BaAl_2S_4$	$Pa\bar{3}$	Cubic	cP84	$BaAl_2S_4$
$BaAl_2Se_4$	P4/nnc	Tetragonal	tP28	BaAl ₂ Se ₄
$BaAl_2Te_4$	P4/nbm	Tetragonal	tP14	$BaAl_2Te_4$
$BaSbBS_4$	Pnma	Orthorhombic	oP28	$KBaPO_4$
$BaBiBS_4$	C2/m	Monoclinic	mS28	$BaBiBS_4$
BaAg ₂ GeS ₄	$I\bar{4}2m$	Tetragonal	<i>tI</i> 16	K_3VO_4
BaAg ₂ SnS ₄	I222	Orthorhombic	<i>oI</i> 16	BaAg ₂ SnS ₄
BaAu ₂ SnS ₄	$P2_{1}2_{1}2$	Orthorhombic	oP32	BaAu ₂ SnS ₄
BaCdSnS ₄	Fdd2	Orthorhombic	oF224	$BaCdSnS_4$
BaHgSnS ₄	Pnn2	Orthorhombic	oP28	BaHgSnS ₄
EuNa ₂ SiSe ₄	R3c	Trigonal	hR48	EuNa ₂ SiSe ₄
EuNa ₂ GeSe ₄	$I\bar{4}3m$	Cubic	<i>cI</i> 16	Tl_3VS_4
$YbCaInS_4$	Pnma	Orthorhombic	oP28	Mg_2SiO_4

^a As there are so many members can be classified to this family, only one compound was chosen as a representative for each type of structure. All these data are checked results from Inorganic Crystal Structure Data (ICSD) and Pearson's Crystal Data (PCD).

obtained by solid-state reactions with KI as flux. The starting materials are stoichiometric mixture of Eu₂O₃, Zn, Ge and S for 1, Eu_2O_3 , Ga_2O_3 and S for 2, Eu_2O_3 , In_2O_3 and S for 3, and Eu_2O_3 , In₂O₃ and Se for 4. A certain amount of boron powder and KI were added to each sample as reducing reagent and flux, respectively. Each sample has a total mass of 500 mg and 400 mg KI additional. The mixtures of starting materials were ground into fine powder in an agate mortar and pressed into pellets, followed by being loaded into quartz tubes. The tubes were evacuated to be 1×10^{-4} torr and flame-sealed. The samples were placed into a muffle furnace, heated from room temperature to 573 K in 5 h and equilibrated for 10 h, followed by heating to 923 K in 5 h and equilibrated for another 10 h, then heated to 1223 K in 5 h and homogenized for 10 days, finally cooled down to 573 K in 5 days and powered off. All the crystals of 1-4 stable in moisture and air were obtained and hand-picked under a microscope since the yields were not high, then washed using ethanol and water under ultrasonic wave, whose purities were confirmed by powder X-ray diffraction (PXRD) study. The PXRD patterns were collected with a Bruker

D8 Advance diffractometer at 40 kV and 100 mA for CuKα radiation ($\lambda = 1.5406 \text{ Å}$) with a scan speed of 5° min⁻¹ at room temperature. The simulated patterns were produced using Mercury v2.3 program provided by the Cambridge Crystallographic Data Center and single-crystal reflection data. A representative PXRD pattern of 3 corresponds well with the simulated one (Fig. 1), indicating it is phase-pure of the selected crystals. Semiquantitative microscope element analysis on the asprepared single crystals was performed on a field-emission scanning electron microscope (FESEM, HITACHI S-4800II) equipped with an energy dispersive X-ray spectroscope (EDS, Bruker, Quantax), which confirmed the presence of each elements with the approximate compositions of 1-4. The exact compositions were established from X-ray determination.

Structure determination. The intensity data set was collected on Bruker D8 QUEST X-ray diffractometer with graphitemonochromated MoK α radiation ($\lambda = 0.71073$ Å). The structures were solved by direct methods and refined by full-matrix least-squares techniques on F2 with anisotropic thermal parameters for all atoms. All the calculations were performed with Siemens Shelxtl-97 crystallographic software package. 16 The final refinement included anisotropic displacement parameters for all atoms and a secondary extinction correction. The crystallographic data, atomic coordinates and equivalent isotropic displacement parameter, and bond lengths are listed in Tables 2, S1 and S2,† respectively. Their CIF documents have also been deposited with Fachinformationszentrum Karlsruhe, 76344 Eggenstein-Leopoldshafen, Germany [fax: +49-7247-808-666; e-mail: crysdata@fiz.karlsruhe.de] with depository number CSD-432057 for 1, CSD-432055 for 2, CSD-432056 for 3 and CSD-432058 for 4.†

UV-Vis-NIR diffuse reflectance spectroscopies. The diffuse reflectance spectra were recorded at the room temperature on

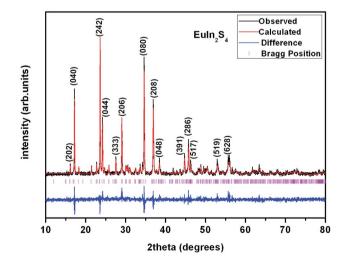


Fig. 1 Powder XRD pattern of 3. Calculated, experimental and residual diffraction patterns are marked with red, black and blue lines, respectively. Bragg reflections are indicated with vertical ticks. The relatively big residuals are caused by the orientation of the crystalline sample.

Table 2 Crystal data and structure refinement parameters of 1-4

Chemical formula	$EuZnGeS_4$ (1)	$EuGa_2S_4$ (2)	$EuIn_2S_4$ (3)	$EuIn_2Se_4$ (4)
$F_{ m w}$	418.16	419.64	509.84	697.44
T(K)	296			
Crystal system	Orthorhombic			
Space group	Fddd			
Z	32			
a (Å)	12.234(4)	12.209(11)	13.016(3)	13.490(1)
b (Å)	20.398(6)	20.445(18)	20.772(5)	21.748(1)
c (Å)	20.682(6)	20.680(19)	21.076(5)	21.859(1)
$V(\mathring{A}^3)$	5161(3)	5162(8)	5699(2)	6412.9(6)
D _{calcd} (g cm ⁻³)	4.305	4.320	4.754	5.779
$\mu (\text{mm}^{-1})$	19.076	19.048	16.166	31.487
F(000)	6048	6048	7200	9504
θ range (°)	2.18 to 25.50	2.18 to 25.49	2.08 to 25.48	2.01 to 27.50
Measd. reflns	5315	2843	9320	7650
Indep. reflns/R _{int}	1203/0.0283	1171/0.0303	1329/0.0581	1844/0.0403
$R_1/wR_2 (I > 2\sigma(I))^a$	0.0483/0.1245	0.0342/0.0841	0.0327/0.0793	0.0287/0.0595
R_1/wR_2 (all data) ^a	0.0553/0.1279	0.0421/0.0894	0.0428/0.0878	0.0493/0.0666
GOF on F ²	1.129	1.145	1.090	1.093
$\Delta ho_{ m max}/\Delta ho_{ m min}$, e Å $^{-3}$	2.571/-1.815	3.368/-2.110	1.627/-2.332	2.042/-1.457

a computer-controlled Lambda 900 UV-Vis-NIR spectrometer equipped with an integrating sphere in the wavelength range of 200–1700 nm. A $BaSO_4$ plate was used as a reference, on which the finely ground powdery sample was coated. The absorption spectra were calculated from reflection spectrum by the Kubelka–Munk function. 17

Calculation details. The calculation models were built directly from the single-crystal diffraction data of 1 and 2. The electronic structure calculation including band structure and density of states based on density functional theory (DFT) was performed using Material Studio. The generalized gradient approximation (GGA) was chosen as the exchange–correlation functional and a plane wave basis with the projector-augmented wave (PAW) potentials was used. The plane-wave cutoff energies of 1 and 2 are 480.0 eV and the threshold of 10^{-5} eV were set for the self-consistent-field convergence of the total electronic energy. The electronic configurations for Eu, Zn, Ge, Ga and S were 4f and 6s, 3d and 4s, 4s and 4p, 4s and 4p, and 3s and 3p, respectively. The numerical integration of the Brillouin zone was performed using $2 \times 2 \times 2$ Monkhorst–Pack k-point meshes and the Fermi level ($E_f = 0$ eV) was selected as the reference.

Results and discussion

Crystal structure

Compounds 1–4 crystallize in the orthorhombic space group Fddd. The crystal structure of 1 is illustrated as a representative as they are isostructural. There are three Eu, one Zn, one Ge and four S atoms in the crystallographically independent unit. Its coordination geometry is shown in Fig. 2. All the three Eu atoms coordinated with eight neighboring S atoms to form EuS₈ bicapped trigonal prisms, Zn and Ge are fourfold-coordinated with four S atoms to form ZnS₄ or GeS₄ tetrahedron.

The structure can be viewed as layered if no consideration of the connection between Eu and S atoms (Fig. 3a). The layers

parallel to the ac plane are constructed by the connection between ZnS₄ and GeS₄ tetrahedra (Fig. 3b). It can be observed that either ZnS₄ or GeS₄ tetrahedra form dimers via sharing edges, respectively, namely, [Zn₂S₆]⁸⁻ or [Ge₂S₆]⁸⁻ units. Both of which are isolated and alternately linked to form the 2D structure. Take the whole structure consideration, the structure of 1 can be described as Eu-S bonds constructed 3D structure, and Zn²⁺ and Ge⁴⁺ cations occupy the tetrahedral cavities (Fig. 4a). It is necessary to understand how the EuS₈ bicapped trigonal prisms connect if we want to know how the 3D structure forms. The Eu atoms arrange regularly along the c direction. Eu(1) atoms arrange in a line along the c direction, while Eu(2) and Eu(3) atoms alternatively arrange in another line along the cdirection. As shown in Fig. 4b, each EuS₈ units has six neighboring EuS₈ units, four of them connect with the central one via sharing edges, while the other two connected via sharing

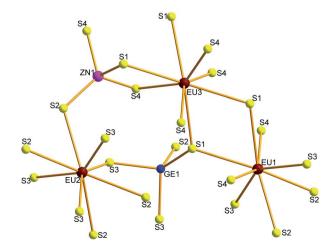


Fig. 2 Coordination geometry of 1.

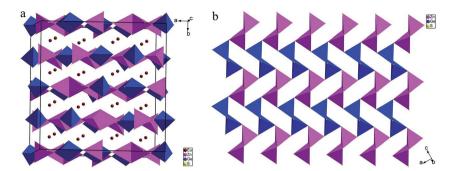


Fig. 3 (a) 2D structure of 1 constructed by the connection between GaS_4 and ZnS_4 tetrahedra. Eu–S bonds are omitted for clarity. (b) The $[ZnGeS_4]^{2-}$ layer viewed along the b direction. GaS_4 and ZnS_4 tetrahedra are represented as pink and blue polyhedra, respectively.

corners. The former and latter have the Eu-Eu distances of 5.208(2) and 5.947(1) Å, respectively.

The Zn–S and Ge–S bond lengths in **1** are in the range of 2.247(4)–2.303(5) and 2.246(4)–2.315(4) Å, respectively, which are in good agreement with 2.243(2)–2.305(2) Å of Ga–S bonds in **2**. These values are consistent with 2.242(1)–2.342(1) Å of Ga–S bonds in (K₃I)[SmB₁₂(GaS₄)₃]. The Eu–S bonds in **1** have the distances of 3.070(4)–3.112(5) Å, similar with those discovered in RbEuGeS₄. The Eu–S bonds in **1** have the distances of 3.070(4)–3.112(5) Å, similar with those discovered in RbEuGeS₄.

As compounds 2–4 have more similar compositions. Here only the comparison is performed between 1 and 2. There are two Ga sites in 2, which can be substituted by one divalent and one tetravalent cations, respectively. So far, there are no quaternary II-III₂ (III-III')-Ch₄ or II-II'(I₂)-IV-Ch₄ compounds reported with *Fddd* structure. Compound 1 represents the first one with this structure. It is interesting to study which one of the two Ga sites will be replaced by divalent cation. First, it has to be mentioned that both of the two Ga atoms occupy 32h sites. Second, both Zn and Ge positions are close to that of Ga in periodic table of the elements, so it is almost impossible to distinguish them by atomic weights when solving the structure.

Third, bond-valence calculation was performed on 2 to help determine which site will be occupied by Zn^{2+} ion, and the other one by Ge^{4+} ion. If Ga(1) and Ga(2) atoms are replaced by Zn and Ge atoms, respectively, their bond valences calculated to be 2.368 and 3.267, respectively. If Zn and Ge exchange their sites, their bond valences are 2.329 and 3.331, respectively. Even the calculation precision is considered, it is still difficult to determine that Ga(1) site is occupied by Zn or Ge atom. The most reasonable solution is that Zn and Ge atoms statistically cooccupy both of two Ge as sites according to the bond-valence calculation results. For simplicity and convenience, the structure of Ge is described above as Ge and Ge atom completely occupy one Ge as ite, respectively. Definitely, the molar ratio of Ge and Ge should be Ge 1: 1 to maintain electric neutrality.

Optical properties

The UV-Vis-NIR diffuse reflectance spectra of 1–3 are shown in Fig. 5. Their optical band gaps are determined to be 2.26, 2.32 and 2.37 eV, respectively, which are consistent with their orange or yellow colors. Comparing these values, it may be proposed that there will be no big band gap change when the Ga atoms in

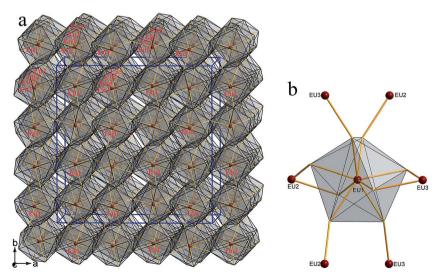


Fig. 4 (a) 3D framework constructed by the three types of EuS8 bicapped trigonal prisms viewed along the c direction; (b) the neighboring Eu(2) and Eu(3) atoms around one Eu(1)S8 unit.

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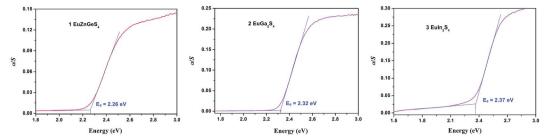
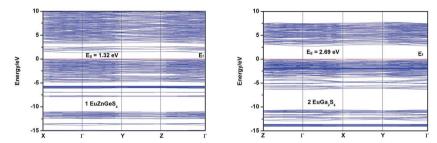


Fig. 5 Diffuse reflection spectra of 1-3.



Calculated band structures of 1 and 2. The Fermi level is chosen as the energy reference at 0 eV.

Table 3 Experimental and calculated optical band gaps of 1-3

		$EuZnGeS_4$ (1)	$EuGa_2S_4$ (2)	EuIn ₂ S ₄ (3)
Band gap (eV)	Experimental Calculated	2.26 1.32	2.32 2.69	2.37

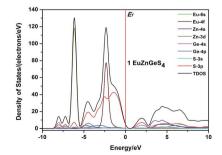
EuGa₂S₄ are replaced by II + IV two types of atoms or by heavier III atoms like In atoms. This supposition may help design II-III₂ (III-III')-Ch₄ or II-II'(I₂)-IV-Ch₄ compounds with tunable band gaps.

Theory investigation

To investigate the electronic structures of 1 and 2, their band structures together with densities of states (DOS) computations based on the DFT theory were performed using Material Studio software. 18 The calculated band structures along high symmetry points of the first Brillouin zone are shown in Fig. 6, from which

it can be seen that the band gaps of 1 and 2 are calculated to be 1.32 and 2.69 eV (Table 3), respectively, the former one is underestimated but reasonable in view of the calculation precision.21 Both the lowest conduction band (CB) and highest valence band (VB) of 1 are located at Γ point, indicating that 1 has a direct band gap. Different from 1, the CB and VB of 2 are located at Γ and X points, respectively, showing that 2 has an indirect band gap.

The total and partial densities of states (DOS and PDOS) of 1 and 2 are plotted in Fig. 7. For 1, the highest VB is mainly constituted of S-3p, and the lowest CB is mainly composed of Ge-4s and S-3p orbitals. The VBs between 0 and -5.0 eV are originated mainly from S-3p and Eu-4f orbitals. The CBs ranging from 2.5 to 7.5 eV are primarily consisted of Ge-4p, and minor Zn-4s and S-3p orbitals. Briefly, the band gap of 1 is determined by the S-3p and Ge-4s orbitals, the respective valence orbitals of S²⁻ and Ge⁴⁺ ions. For 2, the highest VB is mainly constituted of S-3p, and the lowest CB is mainly composed of Ga-4s, S-3p and Ga-4p orbitals, so its band gap is determined by valence orbitals of S2- and Ga3+ ions. The VBs



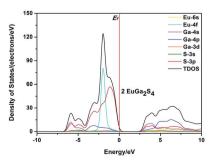


Fig. 7 Calculated density of states (DOS) of 1 and 2. The Fermi level is chosen as the energy reference at 0 eV.

from 0 to -4.0 eV are primarily consisted of S-3p, Eu-4f and minor Ga-4p orbitals. Comparing the PDOS of 1 and 2, it can be concluded that the optical absorptions of 1 and 2 are mainly ascribed to the charge transitions from S-3p to valence orbitals of Ge^{4+} or Ga^{3+} cations.

It is well known that direct or indirect semiconductors have different applications in the optoelectronics research field. From EuGa₂S₄ to EuZnGeS₄, two Ga³⁺ sites are replaced by one Zn²⁺ and one Ge⁴⁺ cations, which is a simple substitution but the parent structure EuGa₂S₄ can be maintained and the measured band gap have a little change. Together with the above discussion, it should be interesting to understand why semiconductor type can be changed while crystal structure and measured band gap keep stable. Besides, it seems the optical absorptions of 1 and 2 have little relationship with the valence orbitals of Eu²⁺, which may give us some rules to explore II-III₂ (III-III')-Ch₄ or II-II'(I₂)-IV-Ch₄ compounds with desirable band gaps for their further photoelectric applications. One example might be used to verify this speculation. Other II-III2-Ch4 compounds containing divalent transition-metal, CdGa2Se4 and HgGa₂Se₄, have direct band gaps of 2.40 and 1.93 eV, respectively, close to our sulfides.22 Besides, it is interesting to find that the calculated band gaps for compounds EuZnGeS4, CdGa₂Se₄ and HgGa₂Se₄ with direct band gaps are much lower than their experimental values.

Conclusions

Four isostructural europium chalcogenides were synthesized using solid-state reactions. Their measured band gaps indicate that they are semiconductors. Interestingly, the band gap type can be tuned from indirect to direct when using one divalent Zn^{2+} and one tetravalent Ge^{4+} cations to substitute the two trivalent Ga^{3+} cations sites in EuGaS_2 . This study may give some experience how to tune structures and band gaps of $\mathrm{II-III}_2$ ($\mathrm{III-III}'$)- Ch_4 or quaternary $\mathrm{II-II}'(\mathrm{I2})$ - $\mathrm{IV-Ch}_4$ compounds ($\mathrm{II}=\mathrm{Mg}$, Ca , Sr , Ba , Eu and Yb ; $\mathrm{II}'=\mathrm{divalent}$ transition metal; $\mathrm{I}=\mathrm{Li}$, Na , Cu and Ag ; $\mathrm{III}=\mathrm{B}$, Al , Ga and In ; $\mathrm{III}'=\mathrm{Yb}$, Sb and Bi ; $\mathrm{IV}=\mathrm{Ge}$ and Sn ; $\mathrm{Ch}=\mathrm{S}$, Se and Te).

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References

(a) K. Mitchell and J. A. Ibers, Chem. Rev., 2002, 102, 1929–1952;
 (b) S.-P. Guo, G.-E. Wang, M.-J. Zhang, M.-F. Wu, G.-N. Liu, X.-M. Jiang, G.-C. Guo and J.-S. Huang, Dalton Trans., 2013, 42, 2679–2682;
 (c) Y. Chi, S.-P. Guo, H.-J. Kong and H.-G. Xue, New J. Chem., 2016, 40, 6720–6727.

- 2 C.-Y. Meng, H. Chen, P. Wang and L. Chen, *Chem. Mater.*, 2011, 23, 4910–4919.
- 3 R. J. Yu, H. K. Yang, B. K. Moon, B. C. Choi and J. H. Jeong, *Phys. Status Solidi A*, 2012, **12**, 2620–2625.
- 4 (a) H. J. Zhao, Y. F. Zhang and L. Chen, J. Am. Chem. Soc.,
 2012, 134, 1993–1995; (b) Y. F. Shi, Y. K. Chen, M. C. Chen,
 L. M. Wu, H. Lin, L. J. Zhou and L. Chen, Chem. Mater.,
 2015, 27, 1876–1884; (c) M. J. Zhang, B. X. Li, B. W. Liu,
 Y. H. Fan, X. G. Li, H. Y. Zeng and G. C. Guo, Dalton
 Trans., 2013, 42, 14223–14229.
- 5 Z. Z. Luo, C. S. Lin, W. L. Zhang, H. Zhang, Z. Z. He and W. D. Cheng, *Chem. Mater.*, 2013, 26, 1093–1099.
- 6 Z. Z. Luo, C. S. Lin, W. D. Cheng, H. Zhang, W. L. Zhang and Z. Z. He, *Inorg. Chem.*, 2012, 52, 273–279.
- 7 K. Feng, X. Jiang, L. Kang, W. Yin, W. Hao, Z. S. Lin, J. Y. Yao, Y. C. Wu and C. T. Chen, *Dalton Trans.*, 2013, 42, 13635– 13641.
- 8 C. Li, W. L. Yin, P. F. Gong, X. S. Li, M. L. Zhou, A. Mar, Z. S. Lin, J. Y. Yao, Y. C. Wu and C. T. Chen, *J. Am. Chem. Soc.*, 2016, 138, 6135–6138.
- 9 K. Wu, X. Su, S. L. Pan and Z. H. Yang, *Inorg. Chem.*, 2015, **54**, 2772–2779.
- 10 K. Wu, X. Su, Z. H. Yang and S. L. Pan, *Dalton Trans.*, 2015, 44, 19856–19864.
- 11 (a) N. Zhen, K. Wu, Y. Wang, Q. Li, W. H. Gao, D. W. Hou, Z. H. Yang, H. D. Jiang, Y. J. Dong and S. L. Pan, Dalton Trans., 2016, 45, 10681–10688; (b) P. C. Donohue and J. E. Hanlon, J. Electrochem. Soc., 1974, 137–142; (c) M. Tampier and D. Johrendt, Z. Anorg. Allg. Chem., 2001, 627, 312–320; (d) T. Sasaki, H. Takizawa, T. Takeda and T. Endo, Mater. Res. Bull., 2003, 38, 33–39; (e) T. Takizawa, C. Komatsu-Hidaka, K. Asaka, T. Isomoto and H. Matsushita, Jpn. J. Appl. Phys., 2000, (Suppl. 39-1), 35–40; (f) A. Assoud, N. Soheilnia and H. Kleinke, Chem. Mater., 2005, 17, 2255–2261.
- 12 (a) O. Gomis, R. Vilaplana, F. J. Manjón, E. Pérez-González, J. López-Solano, P. Rodríguez-Hernández, A. Muñoz, D. Errandonea, J. Ruiz-Fuertes, A. Segura, D. Santamaría-Pérez, I. M. Tiginyanu and V. V. Ursaki, J. Appl. Phys., 2012, 013518; (b) O. Gomis, D. Santamaría-Pérez, R. Vilaplana, R. Luna, J. A. Sans, F. J. Manjón, Errandonea, E. Pérez-González, P. Rodríguez-Hernández, A. Muñoz and V. V. Ursaki, J. Alloys Compd., 2014, 583, 70-78; (c) O. Gomis, R. Vilaplana, F. J. Manjón, Ruiz-Fuertes, E. Pérez-González, J. López-Solano, E. Bandiello, D. Errandonea, A. Segura, P. Rodríguez-Hernández, A. Muñoz, V. V. Ursaki and I. M. Tiginyanu, Phys. Status Solidi B, 2015, 252, 2043-2051; (d) J. Ruiz-Fuertes, D. Errandonea, F. J. Manjón, D. Martínez-García, A. Segura, V. V. Ursaki and I. M. Tiginyanu, J. Appl. Phys., 2008, **103**, 063710; (e) O. Gomis, R. Vilaplana, F. J. Manjón, D. Santamaría-Pérez, D. Errandonea, E. Pérez-González, J. López-Solano, P. Rodríguez-Hernández, A. Muñoz, I. M. Tiginyanu and V. V. Ursaki, J. Appl. Phys., 2013, 113, 073510; (f) D. Errandonea, R. S. Kumar, F. J. Manjón, V. V. Ursaki and I. M. Tiginyanu, J. Appl. Phys., 2008, 104, 063524; (g) D. Errandonea, R. S. Kumar, O. Gomis,

Paper

F. J. Manjón, V. V. Ursaki and I. M. Tiginyanu, *J. Appl. Phys.*, 2013, **114**, 233507; (*h*) D. Santamaría-Pérez, M. Amboage, F. J. Manjón, D. Errandonea, A. Muñoz, P. Rodríguez-Hernández, A. Mújica, S. Radescu, V. V. Ursaki and I. M. Tiginyanu, *J. Phys. Chem. C*, 2012, **116**, 14078–14087; (*i*) O. Gomis, R. Vilaplana, F. J. Manjón, D. Santamaría-Pérez, D. Errandonea, E. Pérez-González, J. López-Solano, P. Rodríguez-Hernández, A. Muñoz, I. M. Tiginyanu and

13 (a) S.-P. Guo, Y. Chi and H.-G. Xue, *Inorg. Chem.*, 2015, 54, 11052–11054; (b) Y. Chi and S.-P. Guo, *J. Mol. Struct.*, 2017, 1127, 53–58; (c) Y. Chi, H.-J. Kong and S.-P. Guo, *Inorg. Chim. Acta*, 2016, 448, 56–60; (d) S.-P. Guo, Y. Chi, B.-W. Liu and G.-C. Guo, *Dalton Trans.*, 2016, 45, 10459–10465; (e) S.-P. Guo and G.-C. Guo, *J. Mater. Chem. A*, 2014, 2, 20621–20628; (f) S.-P. Guo, Y. Chi, J.-P. Zou and H.-G. Xue, *New J. Chem.*, 2016, 40, 10219–10226.

V. V. Ursaki, Mater. Res. Bull., 2013, 48, 2128-2133.

- 14 O. M. Aliev, Inorg. Mater., 1980, 16, 1027-1031.
- 15 (a) R. Roques, R. Rimet, J. P. Declercq and G. Germain, *Acta Crystallogr., Sect. B: Struct. Crystallogr. Cryst. Chem.*, 1979, 35, 555–557; (b) T. E. Peters and J. A. Baglio, *J. Electrochem. Soc.*, 1972, **119**, 230–236.
- 16 Siemens, SHELXTLTM Version 5 Reference Manual, Siemens Energy & Automation Inc., Madison, Wisconsin, USA, 1994.

- 17 (a) W. W. Wendlandt and H. G. Hecht, *Reflectance Spectroscopy*, Interscience Publishers, New York, 1966; (b) G. Kortüm. *Reflectance Spectroscopy*, Springer, 1969.
- 18 M. D. Segall, P. J. D. Lindan, M. J. Probert, C. J. Pickard, P. J. Hasnip, S. J. Clark and M. C. Payne, *J. Phys.: Condens. Matter*, 2002, **14**, 2717–2744.
- 19 S. P. Guo, G. C. Guo, M. S. Wang, J. P. Zou, H. Y. Zeng, L. Z. Cai and J. S. Huang, *Chem. Commun.*, 2009, 4366–4368.
- 20 A. Choudhury, L. A. Polyakova, I. Hartenbach, T. Schleid and P. K. Dorhout, Z. Anorg. Allg. Chem., 2006, 632, 2395–2401.
- 21 (a) D. Errandonea, D. Martínez-García, R. Lacomba-Perales, J. Ruiz-Fuertes and A. Segura, Appl. Phys. Lett., 2006, 89, 091913; (b) R. Lacomba-Perales, D. Errandonea, A. Segura, P. Rodríguez-Hernández, S. Radescu, J. López-Solano, A. Mujica and A. Muñoz, J. Appl. Phys., 2011, 110, 043703; (c) V. Panchal, D. Errandonea, A. Segura, P. Rodríguez-Hernández, A. Muñoz, S. Lopez-Moreno and M. Bettinelli, J. Appl. Phys., 2011, 110, 043723.
- 22 F. J. Manjón, O. Gomis, P. Rodríguez-Hernández, E. Pérez-González, A. Muñoz, D. Errandonea, J. Ruiz-Fuertes, A. Segura, M. Fuentes-Cabrera, I. M. Tiginyanu and V. V. Ursaki, *Phys. Rev. B: Condens. Matter Mater. Phys.*, 2010, 81, 195201.